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SHEET 1 OF 1

Form PTO 1449	U.S. DEPARTMENT OF COMMERCE			ATTY DOCKET NO.		SERIAL NO.		
(Modified)		PATENT AND TRA	DEMARK OFFICE	296582US2PCT		10/593,255		
	51.6			APPLICANT				
		RENGES CITED BY AF	PPLICANT	Woosuck SHIN, et al.				
₹				FILING DATE		GROUP		
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13 CONTRICTOR								
EXAMINE INITIAL	10EMA	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
	AA							
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FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION		
/D E /	10		0.4/4.0/04			YES		
<u>/R.E./</u>	AO	JP 2001-099801 A	04/13/01	Japan		_	X	
	AP	JP 2929789 B2 · JP 10-26594 A	05/21/99 01/27/98	Japan (with English Abstract) Japan (with English Abstract)			X	
	AQ	JP 2000-275203 A	10/06/00	Japan (with English Abstract)			X	
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1/	AT	JP 2003-233394 A	11/07/03	Japan (with English Abstract)			×	
	AU	JP 08-278274	10/22/96	Japan			×	
-	AV	01 00 210211	10/22/00	Capan				
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
/R.E./	AW	Varadan Vijay, et al. "Microsensors, MEMS, and Smart Devices." pages 280-302						
		SMAYE CAESADANO III I. 2 I EMIS II "Colleidal late for Discaled Assembly of C.D.D. 22 To Co. 1. III. 1.						
/R.E./	AX	SMAY E., CAESARANO III J., & LEWIS J: "Colloidal Inks for Directed Assembly of 3-D Periodic Structures" Materials Science & Engineering Department, University of Illinois at Urbana-Champaign, Urbana, Illinois 61801, and Sandia National Laboratories, Albuquerque, New Mexico 87106. Langmuir 2002, 18, 5429-5437. 2002 American Chemical Society.						
/R.E./	AY	J.E. Smay, Langmuir 2002, 18, 5429						
	AZ				Addit	ional Refer	rences sheet(s) attached	
Examiner	Aminer /Robert Eom/ Date Considered 03/16/200						03/16/2009	
*Examiner: In conformance	*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							